

<b>Notice of References Cited</b>	Application/Control No. 09/892,506	Applicant(s)/Patent Under Reexamination MURAYAMA ET AL.	
	Examiner Gary C. Vieaux	Art Unit 2622	Page 1 of 1

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*	C	US-6,037,655	03-2000	Philbrick et al.	257/680
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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